

#2/6-20-02  
v Jones

# INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Substitute for form 1449A/PTO

Sheet 1 of 3  
(use as many sheets as necessary)

Complete if Known  
Application Number 09/976,170  
Filing Date 10-12-01  
First Named Inventor Zerbe, et al.  
Group Art Unit 2132  
Examiner Name Unknown  
Attorney Docket Number 1726.7220801

## U.S. PATENT DOCUMENTS

Examiner Initials *	Cite No. 1	U.S. Patent Document Number Kind Code 2 (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
7/10	AA	US2001/0016929 A1	Bonneau et al.	08-23-2001	
7/10	AB	US2001/0021987 A1	Govindarajan et al.	09-13-2001	
7/10	AC	US 5,917,856	Torsti	06-29-1999	
7/10	AD	US 6,222,380 B1	Gerowitz et al.	04-24-2001	
7/10	AE	US 6,289,045 B1	Hasegawa et al.	09-11-2001	
7/10	AF	US 6,292,116 B1	Wang et al.	09-18-2001	
	AG				
	AH				
	AI				
	AJ				

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7/10	AK	EP 1 134 668 A2	Lucent Technologies	09-19-2001		<input type="checkbox"/>
	AL					<input type="checkbox"/>
	AM					<input type="checkbox"/>
	AN					<input type="checkbox"/>
	AO					<input type="checkbox"/>

## PUBLICATIONS

Examiner Initials *	Cite No. 1	Title of Publication	Date of Publication of Cited Document MM-DD-YYYY
7/10	AP	The Ouroboros of the Digital Consciousness...	01-04-1996
7/10	AQ	Test High-Speed Drivers with Bursts...	05-12-1994
7/10	AR	Use LFSRs to Build Fast FPGA-Based Counters	03-21-1994
7/10	AS	Accurate On-Chip Interconnect Evaluation...	05-1999

Examiner Signature	<i>John Zerbe</i>	Date Considered	2/13/04
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Unique citation designation number. 2 See attached Kinds of U.S. Patent Documents. 3 Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). 4 For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. 5 Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. 6 Applicant is to place a check mark here if English language Translation is attached.

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	AM						<input type="checkbox"/>
	AN						<input type="checkbox"/>
	AO						<input type="checkbox"/>

## PUBLICATIONS

Examiner Initials *	Cite No. 1	Title of Publication	Date of Publication of Cited Document MM-DD-YYYY
JAF	AT	Multi-gigabit Signaling with CMOS	05-12-1997
JAF	AU	HOTLink Built-In Self-Test (BIST)	03-11-1999
JAF	AV	Accurate <i>In Situ</i> Measurement of Peak Noise and Delay Change...	10-2001
JAF	AW	Characterization of Individual Weights in Transversal Filters...	12-1982

Examiner Signature	<i>John Zerbe</i>	Date Considered	2/13/04
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	AM						<input type="checkbox"/>
	AN						<input type="checkbox"/>
	AO						<input type="checkbox"/>

## PUBLICATIONS

Examiner Initials *	Cite No. 1	Title of Publication	Date of Publication of Cited Document MM-DD-YYYY
MP	AX	Wide-Band Network Characterization by Fourier Transformation...	08-1969
MP	AY	Modeling of High-Speed, Large-Signal Transistor Switching...	04-1982
	AZ		

Examiner Signature	Date Considered
<i>John Zerbe</i>	2/13/84

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